



60V 1.8mΩ N-Ch Power MOSFET

Features

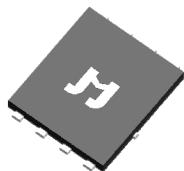
- Ultra-low ON-resistance, $R_{DS(ON)}$
- Low Gate Charge, Q_g
- 100% UIS and R_g Tested
- Pb-free Lead Plating
- Halogen-free and RoHS-compliant
- AEC-Q101 Qualified for Automotive Applications

Product Summary

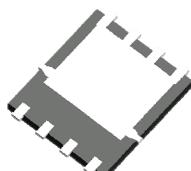
Parameter	Value	Unit
V_{DS}	60	V
$V_{GS(th)}_{Typ}$	1.7	V
$I_D (@ V_{GS} = 10V)$ ⁽¹⁾	172	A
$R_{DS(ON)}_{Typ} (@ V_{GS} = 10V)$	1.8	mΩ
$R_{DS(ON)}_{Typ} (@ V_{GS} = 4.5V)$	2.4	mΩ

PDFN5x6-8L

Top View

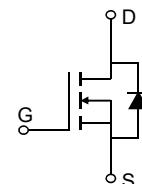
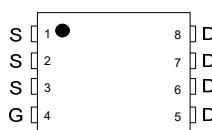


Bottom View



Pin Configuration

Top View

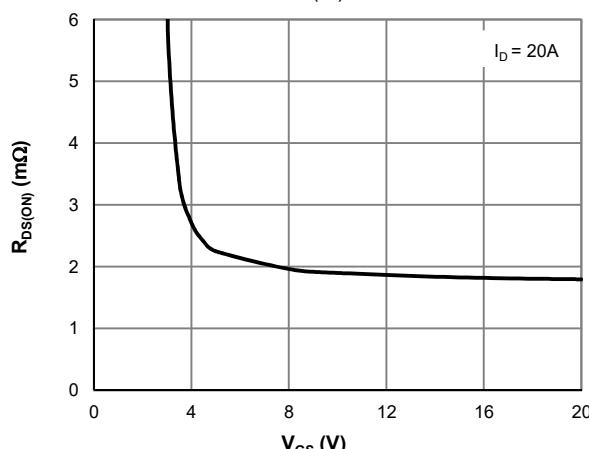


Ordering Information

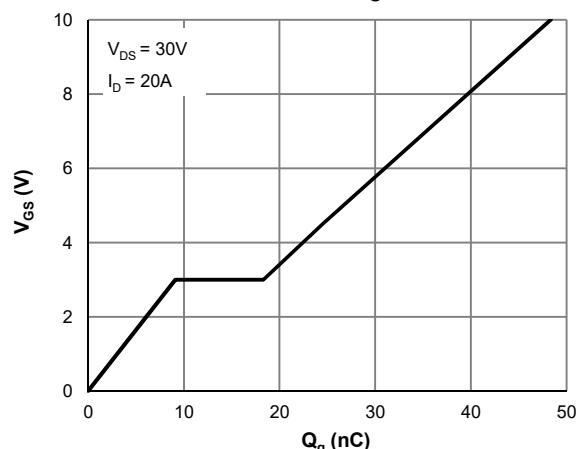
Device	Package	# of Pins	Marking	MSL	T_J (°C)	Media	Quantity (pcs)
JMSL0602AGQ-13	PDFN5x6-8L	8	SL0602AQ	1	-55 to 175	13-inch Reel	3000

Absolute Maximum Ratings (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DS}	60	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current (1)	I_D	172	A
$T_C = 100^\circ\text{C}$		121	
Pulsed Drain Current (2)	I_{DM}	687	A
Avalanche Current (3)	I_{AS}	40	A
Avalanche Energy (3)	E_{AS}	240	mJ
Power Dissipation (4)	P_D	167	W
$T_C = 100^\circ\text{C}$		83	
Junction & Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C

 $R_{DS(ON)}$ vs. V_{GS} 

Gate Charge



**Electrical Characteristics (@ $T_J = 25^\circ\text{C}$ unless otherwise specified)**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	60			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 48\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$			1.0 5.0	μA
Gate-Body Leakage Current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$			± 100	nA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.7	2.5	V
Static Drain-Source ON-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 20\text{A}$		1.8	2.3	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 15\text{A}$		2.4	3.2	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = 5\text{V}, I_D = 20\text{A}$		136		S
Diode Forward Voltage	V_{SD}	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.65	1.0	V
Diode Continuous Current	I_S	$T_C = 25^\circ\text{C}$			167	A
DYNAMIC PARAMETERS⁽⁵⁾						
Input Capacitance	C_{iss}	$V_{GS} = 0\text{V}, V_{DS} = 30\text{V}, f = 1\text{MHz}$		2880		pF
Output Capacitance	C_{oss}			958		pF
Reverse Transfer Capacitance	C_{rss}			44		pF
Gate Resistance	R_g	$V_{GS} = 0\text{V}, V_{DS} = 0\text{V}, f = 1\text{MHz}$		2.0		Ω
SWITCHING PARAMETERS⁽⁵⁾						
Total Gate Charge (@ $V_{GS} = 10\text{V}$)	Q_g	$V_{GS} = 0 \text{ to } 10\text{V}$ $V_{DS} = 30\text{V}, I_D = 20\text{A}$		48		nC
Total Gate Charge (@ $V_{GS} = 4.5\text{V}$)	Q_g			25		nC
Gate Source Charge	Q_{gs}			9.1		nC
Gate Drain Charge	Q_{gd}			9.2		nC
Turn-On DelayTime	$t_{D(\text{on})}$	$V_{GS} = 10\text{V}, V_{DS} = 30\text{V}$ $R_L = 1.5\Omega, R_{\text{GEN}} = 6\Omega$		2.6		ns
Turn-On Rise Time	t_r			6.7		ns
Turn-Off DelayTime	$t_{D(\text{off})}$			41		ns
Turn-Off Fall Time	t_f			16.4		ns
Body Diode Reverse Recovery Time	t_{rr}	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		60		ns
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		70		nC

Thermal Performance

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta,\text{JA}}$	45	55	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	$R_{\theta,\text{JC}}$	0.90	1.2	$^\circ\text{C/W}$

Notes:

1. Computed continuous current assumes the condition of $T_{J,\text{Max}}$ while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under $T_{J,\text{Max}} = 175^\circ\text{C}$.
3. This single-pulse measurement was taken under the following condition [$L = 300\mu\text{H}, V_{GS} = 10\text{V}, V_{DD} = 30\text{V}$] while its value is limited by $T_{J,\text{Max}} = 175^\circ\text{C}$.
4. The power dissipation P_D is based on $T_{J,\text{Max}} = 175^\circ\text{C}$.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Electrical & Thermal Characteristics

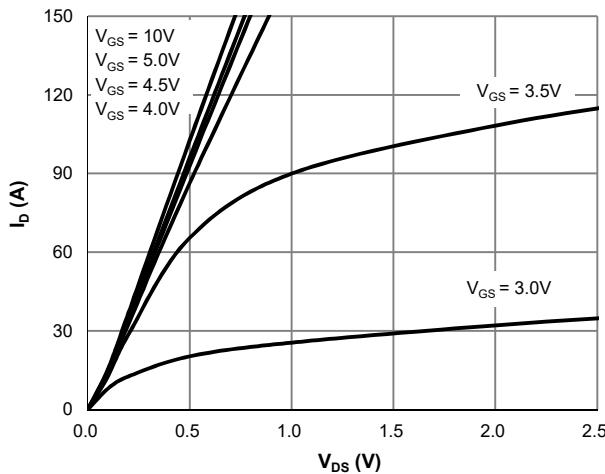


Figure 1: Saturation Characteristics

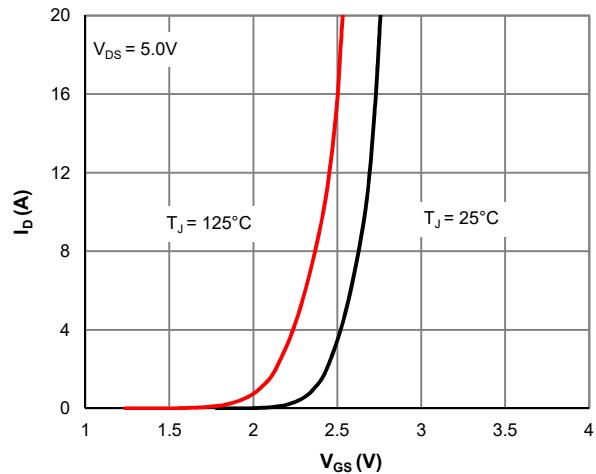


Figure 2: Transfer Characteristics

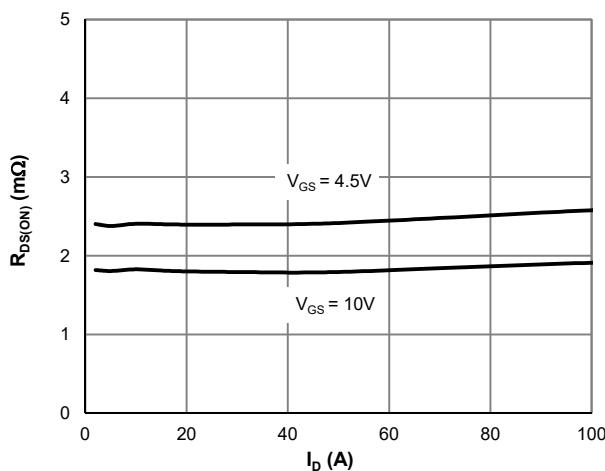


Figure 3: $R_{DS(on)}$ vs. Drain Current

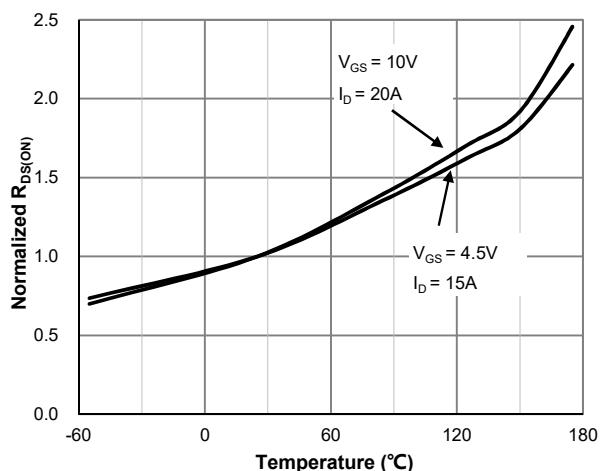


Figure 4: $R_{DS(on)}$ vs. Junction Temperature

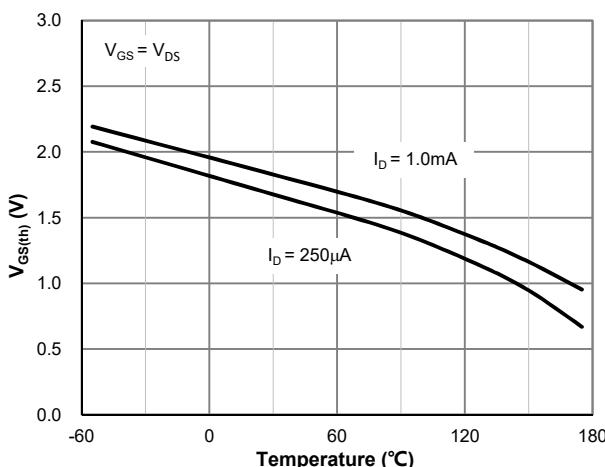


Figure 5: $V_{GS(th)}$ vs. Junction Temperature

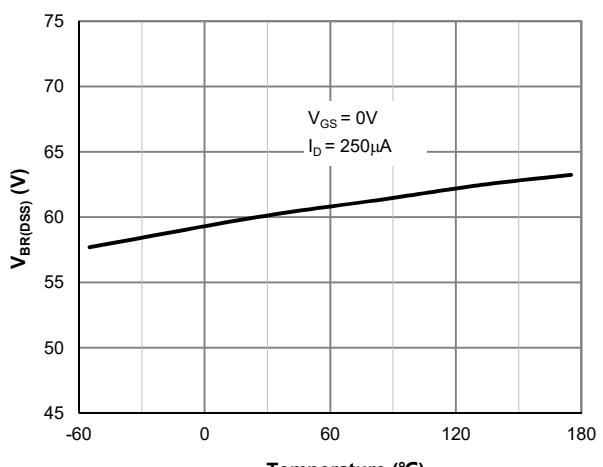


Figure 6: $V_{BR(DSS)}$ vs. Junction Temperature

Typical Electrical & Thermal Characteristics

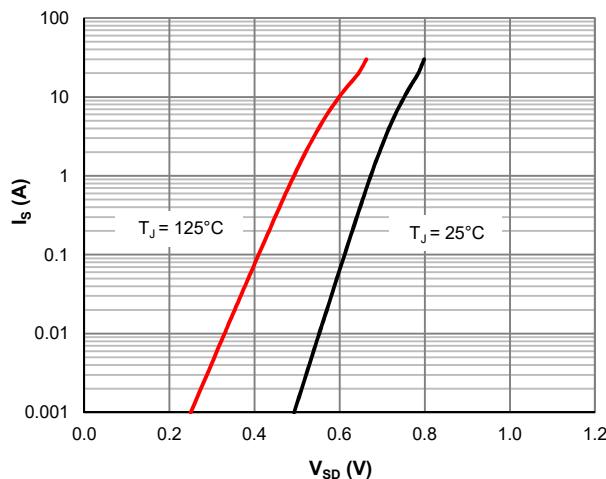


Figure 7: Body-Diode Characteristics

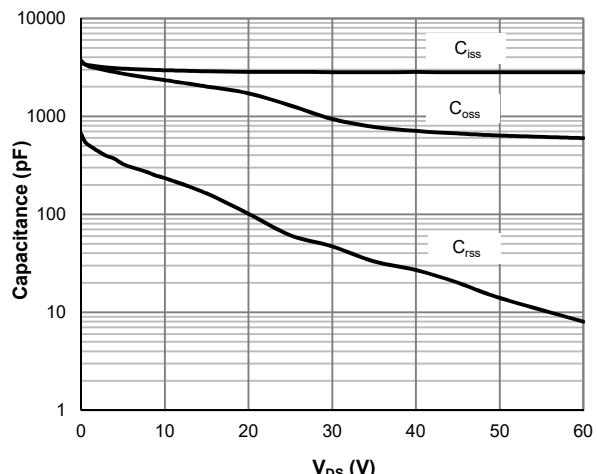


Figure 8: Capacitance Characteristics

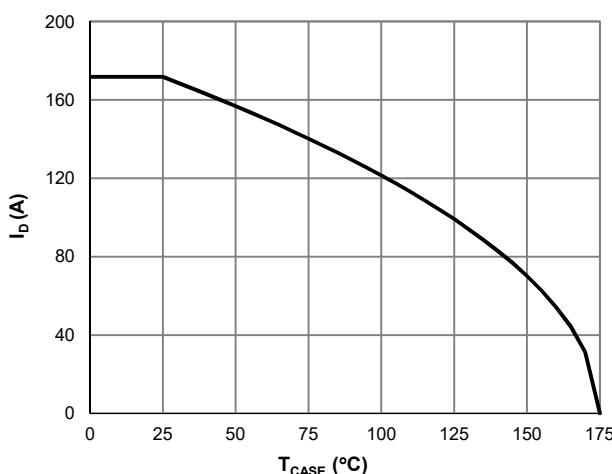


Figure 9: Current De-rating

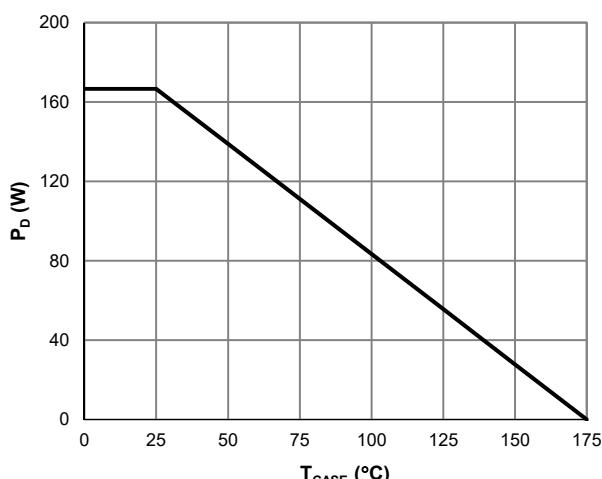


Figure 10: Power De-rating

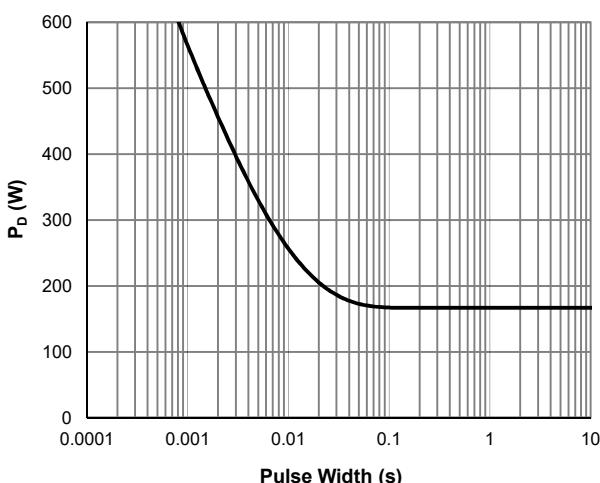


Figure 11: Single Pulse Power Rating, Junction-to-Case

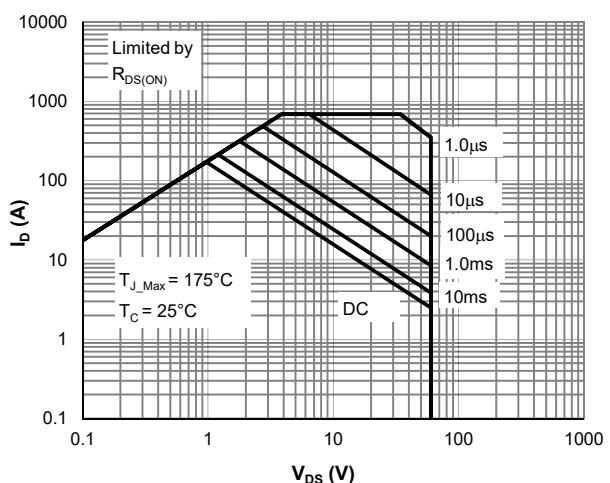


Figure 12: Maximum Safe Operating Area

Typical Electrical & Thermal Characteristics

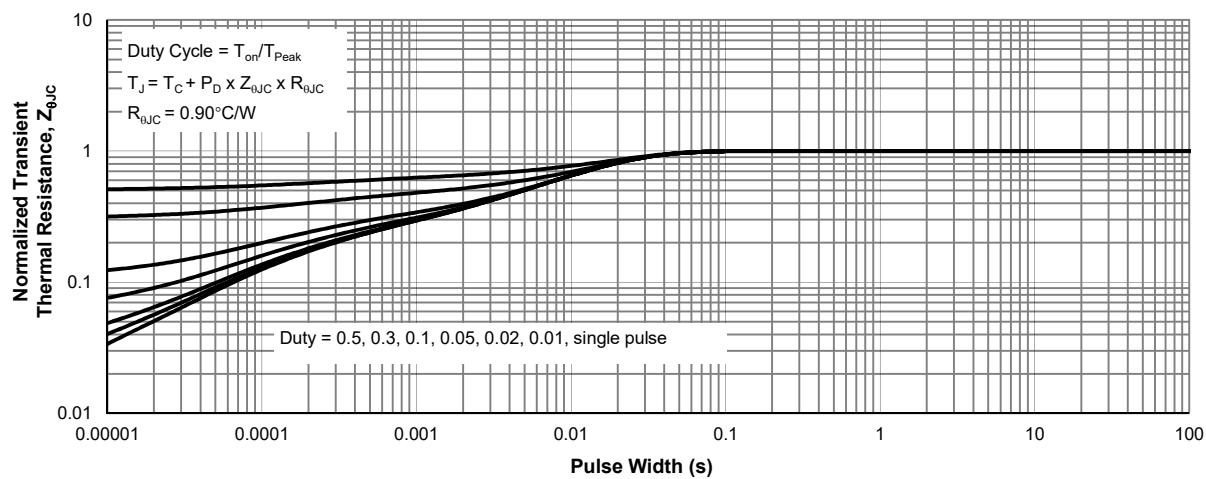
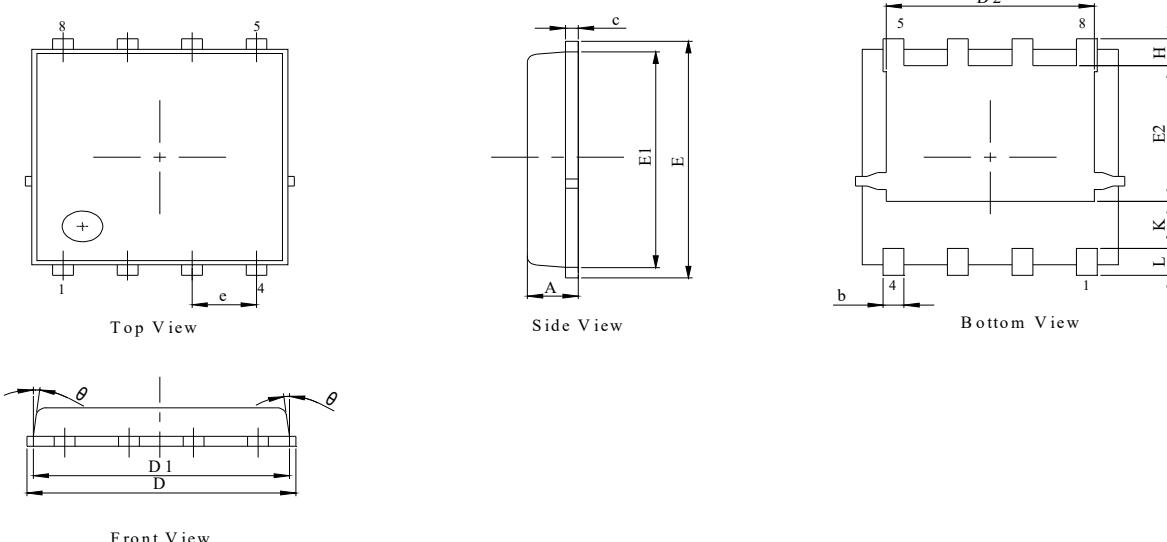


Figure 13: Normalized Maximum Transient Thermal Impedance

PDFN5x6-8L Package Information
Package Outline

NOTES:

1. Dimension and tolerance per ASME Y14.5M, 1994.
2. All dimensions in millimeter (angle in degree).
3. Dimensions D1 and E1 do not include mold flash protrusions or gate burrs.

DIM .	MILLIMETER		
	M IN .	N O M .	M AX .
A	0.90	1.00	1.10
b	0.31	0.41	0.51
c	0.20	0.25	0.30
D	5.00	5.20	5.40
D1	4.95	5.05	5.15
D2	4.00	4.10	4.20
E	6.05	6.15	6.25
E1	5.50	5.60	5.70
E2	3.42	3.53	3.63
e	1.27BSC		
H	0.60	0.70	0.80
L	0.50	0.70	0.80
K	1.23 REF		
θ	-	-	10°

Recommended Soldering Footprint
